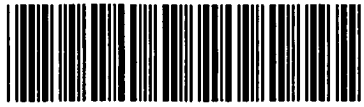


<b>Search Notes</b>  	<b>Application/Control No.</b>  10607907	<b>Applicant(s)/Patent Under Reexamination</b>  SNADER ET AL.
	<b>Examiner</b>  Zhen, Li B	<b>Art Unit</b>  2194

SEARCHED			
Class	Subclass	Date	Examiner
719	328	7/21/2007	LZ
715	507, 780	7/21/2007	LZ
update	search	12/12/07	LZ

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	7/21/2007	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	12/12/07	LZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner